Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/807,714	CHEN ET AL.	
Examiner	Art Unit	
Tuan Quach	2826	

SEARCHED			
Class	Subclass	Date	Examiner
257	78, 200, 442, 614	7/6/2006	TQ
			:
			:

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (USPAT; USPGPUG; EPO; JPO; DERWENT; IBMTDB) - see search history printout	7/6/2006	TQ	